

AO4404A

N-Channel Enhancement Mode Field Effect Transistor



General Description

The AO4404A uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance. Standard Product AO4404A is Pb-free (meets ROHS & Sony 259 specifications). AO4404AL is a Green Product ordering option. AO4404A and AO4404AL are electrically identical.

Features

 $V_{DS}(V) = 30V$

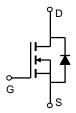
 $I_D = 8.5A (V_{GS} = 10V)$

 $R_{DS(ON)}$ < 24m Ω (V_{GS} = 10V)

 $R_{DS(ON)}$ < 30m Ω (V_{GS} = 4.5V)

 $R_{DS(ON)}$ < 48m Ω (V_{GS} = 2.5V)





Absolute Maximum Ratings T _A =25°C unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		V_{DS}	30	V				
Gate-Source Voltage		V_{GS}	±12	V				
Continuous Drain	T _A =25°C		8.5					
Current ^A	T _A =70°C	I _D	7.1	Α				
Pulsed Drain Current ^B		I _{DM}	60					
	T _A =25°C	D	2.8	W				
Power Dissipation	T _A =70°C	$-P_D$	1.8	VV				
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	°C				

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	37	45	°C/W			
Maximum Junction-to-Ambient ^A	Steady-State	κ_{θ} JA	70	100	°C/W			
Maximum Junction-to-Lead ^C	Steady-State	$R_{ heta JL}$	26	36	°C/W			

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Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC I	PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V			0.002	1	
			T _J =55°C			5	μА
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} = ±12V				100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS} I_D=250 \mu A$		0.7	1	1.5	V
I _{D(ON)}	On state drain current	V _{GS} =4.5V, V _{DS} =5V		40			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =8.5A			18	24	mΩ
			T _J =125°C		25	30	
		V _{GS} =4.5V, I _D =8.5A			22	30	mΩ
		V _{GS} =2.5V, I _D =5A		32	48	mΩ	
g FS	Forward Transconductance	V_{DS} =5V, I_{D} =5A		10	26		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.71	1	V
I _S	Maximum Body-Diode Continuous Current					4.5	Α
DYNAMIC	CPARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			900	1100	pF
C _{oss}	Output Capacitance				88		pF
C _{rss}	Reverse Transfer Capacitance				65		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			0.95	1.5	Ω
SWITCHI	NG PARAMETERS	<u>.</u>					
Q_g	Total Gate Charge	V _{GS} =4.5V, V _{DS} =15V, I _D =8.5A			10	12	nC
Q_{gs}	Gate Source Charge				1.8		nC
Q_{gd}	Gate Drain Charge				3.75		nC
t _{D(on)}	Turn-On DelayTime				3.2		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =1.8 Ω , R_{GEN} =6 Ω			3.5		ns
$t_{D(off)}$	Turn-Off DelayTime				21.5		ns
t _f	Turn-Off Fall Time				2.7		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =5A, dI/dt=100A/μs			16.8	20	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =5A, dI/dt=100A/μs			8	12	nC

A: The value of $R_{\theta JA}$ is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t≤ 10s thermal resistance rating.

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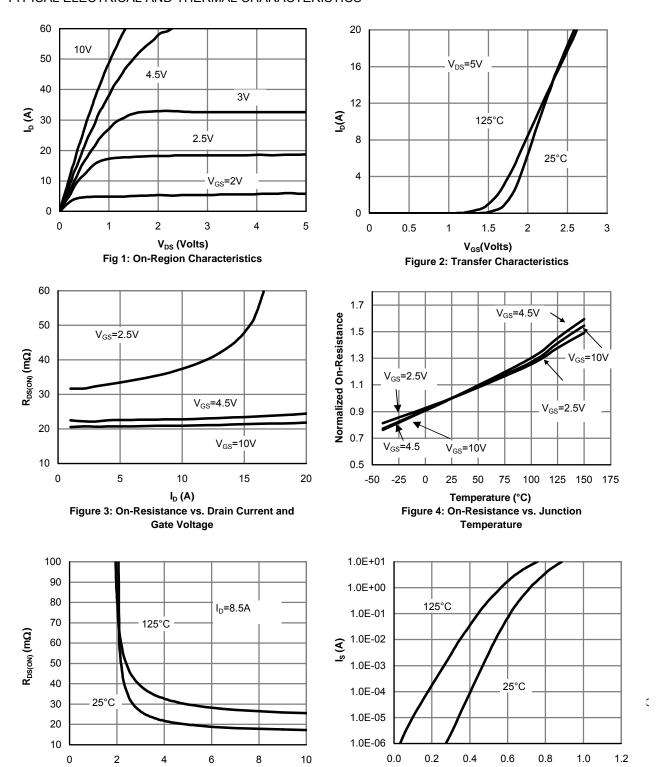
B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using $80\mu s$ pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25 °C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



V_{SD} (Volts)

Figure 6: Body-Diode Characteristics

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V_{GS} (Volts)

Figure 5: On-Resistance vs. Gate-Source Voltage

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

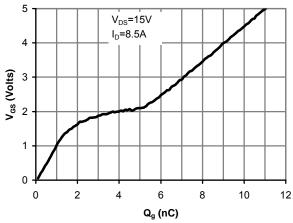


Figure 7: Gate-Charge Characteristics

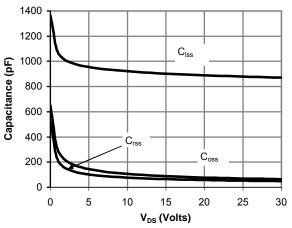


Figure 8: Capacitance Characteristics

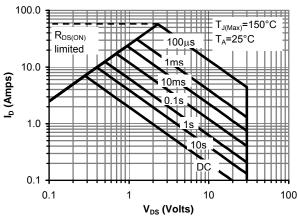


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

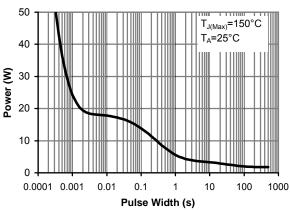


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

C

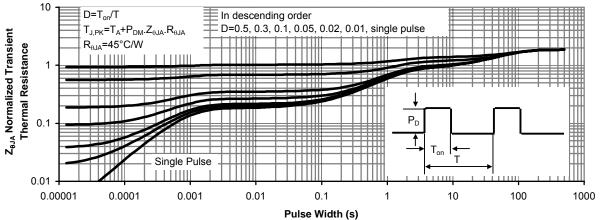


Figure 11: Normalized Maximum Transient Thermal Impedance

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